Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination PERRAULT ET AL.	
09/713,296		
Examiner	Art Unit	_
 Phi D Δ	3637	

SEARCHED							
Class	Subclass	Date	Examiner				
<u>-</u>							
··· -							
ı			1				

INT	INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner			
		<u>.</u>				